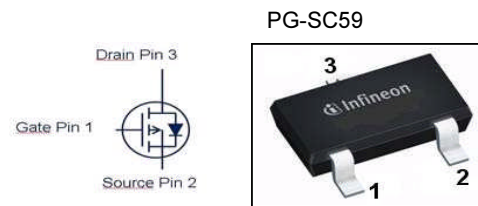


**SIPMOS<sup>®</sup> Small-Signal-Transistor**
**Features**

- P-Channel
- Enhancement mode / Logic level
- Avalanche rated
- Pb-free lead plating; RoHS compliant
- Footprint compatible to SOT23

**Product Summary**

$V_{DS}$	-250	V
$R_{DS(on),max}$	11	$\Omega$
$I_D$	-0.14	A



Type	Package	Tape and Reel Information	Marking	Lead free	Packing
BSR92P	PG-SC59	L6327 = 3000 pcs. / reel	LD	Yes	Non dry

**Maximum ratings, at  $T_j=25\text{ }^\circ\text{C}$ , unless otherwise specified**

Parameter	Symbol	Conditions	Value	Unit
			steady state	
Continuous drain current	$I_D$	$T_A=25\text{ }^\circ\text{C}$	-0.14	A
		$T_A=70\text{ }^\circ\text{C}$	-0.11	
Pulsed drain current	$I_{D,pulse}$	$T_A=25\text{ }^\circ\text{C}$	-0.56	
Avalanche energy, single pulse	$E_{AS}$	$I_D=-0.14\text{ A}, R_{GS}=25\text{ }\Omega$	24	mJ
Gate source voltage	$V_{GS}$		$\pm 20$	V
Power dissipation	$P_{tot}$	$T_C=25\text{ }^\circ\text{C}$	0.5	W
Operating and storage temperature	$T_j, T_{stg}$		-55 ... 150	$^\circ\text{C}$
ESD class		JESD22-A114 (HBM)	1A (250V to 500V)	
Soldering temperature			260 $^\circ\text{C}$	
IEC climatic category; DIN IEC 68-1			55/150/56	

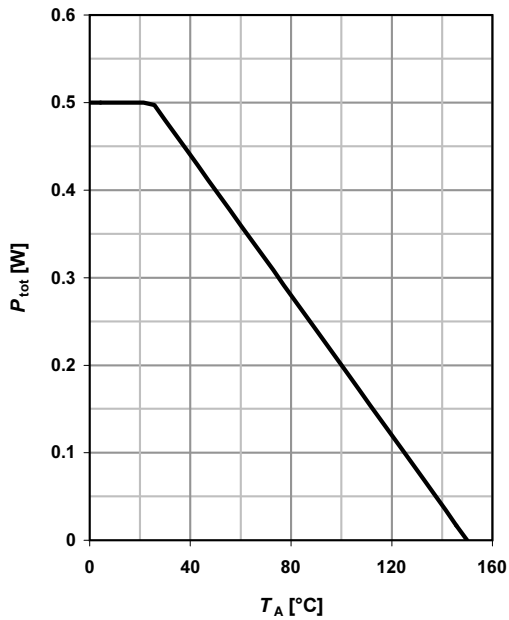
Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
<b>Thermal characteristics</b>						
Thermal resistance, junction - ambient	$R_{thJA}$	minimal footprint, steady state	-	-	250	K/W
<b>Electrical characteristics, at <math>T_j=25\text{ }^\circ\text{C}</math>, unless otherwise specified</b>						
<b>Static characteristics</b>						
Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0\text{ V}$ , $I_D=-250\text{ }\mu\text{A}$	-250	-	-	V
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}$ , $I_D=-130\text{ }\mu\text{A}$	-2	-1.5	-1	
Zero gate voltage drain current	$I_{DSS}$	$V_{DS}=-250\text{ V}$ , $V_{GS}=0\text{ V}$ , $T_j=25\text{ }^\circ\text{C}$	-	-0.1	-1	$\mu\text{A}$
		$V_{DS}=-250\text{ V}$ , $V_{GS}=0\text{ V}$ , $T_j=150\text{ }^\circ\text{C}$	-	-10	-100	
Gate-source leakage current	$I_{GSS}$	$V_{GS}=-20\text{ V}$ , $V_{DS}=0\text{ V}$	-	-10	-100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS}=-2.8\text{ V}$ , $I_D=-0.025\text{ A}$	-	11	20	$\Omega$
		$V_{GS}=-4.5\text{ V}$ , $I_D=-0.13\text{ A}$	-	9	13	
		$V_{GS}=-10\text{ V}$ , $I_D=-0.14\text{ A}$	-	8	11	
Transconductance	$g_{fs}$	$ V_{DS} >2 I_D R_{DS(on)max}$ , $I_D=-0.11\text{ A}$	0.1	0.3	-	S

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
<b>Dynamic characteristics</b>						
Input capacitance	$C_{iss}$	$V_{GS}=0\text{ V}, V_{DS}=-25\text{ V},$ $f=1\text{ MHz}$	-	82	109	pF
Output capacitance	$C_{oss}$		-	12	16	
Reverse transfer capacitance	$C_{rss}$		-	5	8	
Turn-on delay time	$t_{d(on)}$	$V_{DD}=-125\text{ V},$ $V_{GS}=-10\text{ V},$ $I_D=-0.14\text{ A}, R_G=6\ \Omega$	-	6.4	9.0	ns
Rise time	$t_r$		-	6.3	9.0	
Turn-off delay time	$t_{d(off)}$		-	75.0	112	
Fall time	$t_f$		-	71.0	163	
<b>Gate Charge Characteristics<sup>2)</sup></b>						
Gate to source charge	$Q_{gs}$	$V_{DD}=-200\text{ V}, I_D=-$ $0.14\text{ A}, V_{GS}=0\text{ to }-10\text{ V}$	-	-0.2	-0.3	nC
Gate to drain charge	$Q_{gd}$		-	-1.2	-1.8	
Gate charge total	$Q_g$		-	-3.6	-4.8	
Gate plateau voltage	$V_{plateau}$		-	-2.7	-	V
<b>Reverse Diode</b>						
Diode continuous forward current	$I_S$	$T_C=25\text{ }^\circ\text{C}$	-	-	-0.14	A
Diode pulse current	$I_{S,pulse}$		-	-	-0.56	
Diode forward voltage	$V_{SD}$	$V_{GS}=0\text{ V}, I_F=0.14\text{ A},$ $T_J=25\text{ }^\circ\text{C}$	-	-0.8	-1.2	V
Reverse recovery time	$t_{rr}$	$V_R=125\text{ V}, I_F= I_S ,$ $di_F/dt=100\text{ A}/\mu\text{s}$	-	66	-	ns
Reverse recovery charge	$Q_{rr}$		-	125	-	nC

<sup>2)</sup> See figure 16 for gate charge parameter definition

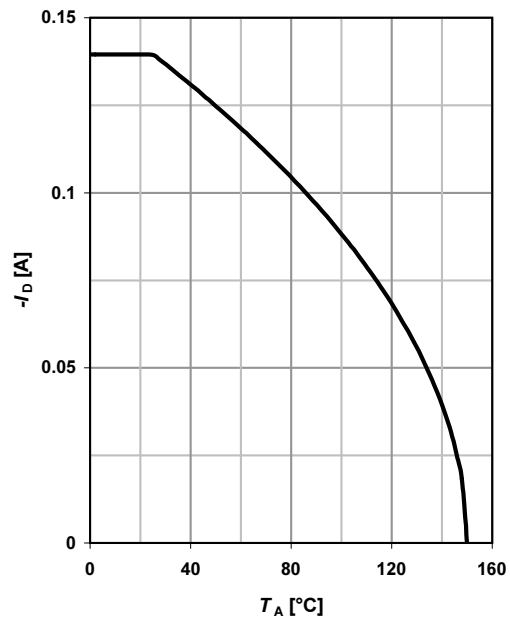
**1 Power dissipation**

$$P_{tot} = f(T_C)$$



**2 Drain current**

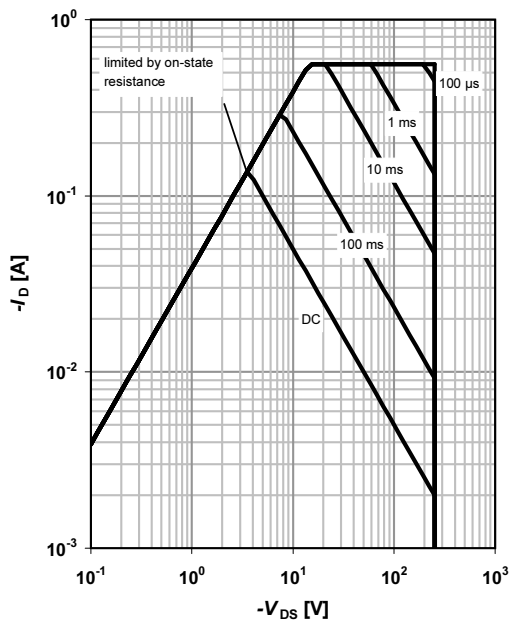
$$I_D = f(T_C); |V_{GS}| \geq 10 \text{ V}$$



**3 Safe operating area**

$$I_D = f(V_{DS}); T_C = 25 \text{ °C}; D = 0$$

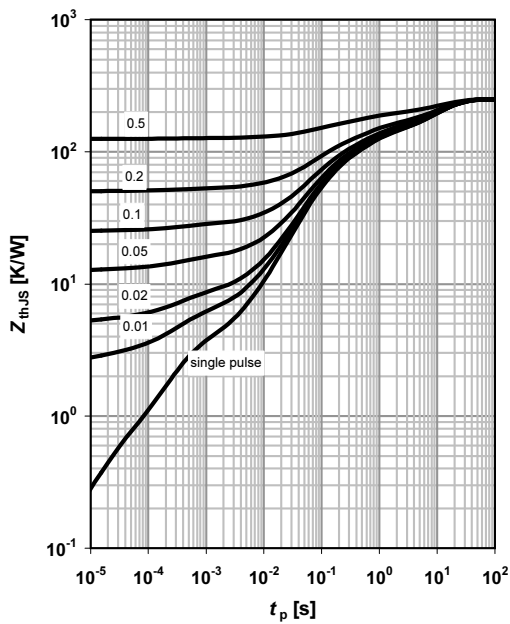
parameter:  $t_p$



**4 Max. transient thermal impedance**

$$Z_{thJC} = f(t_p)$$

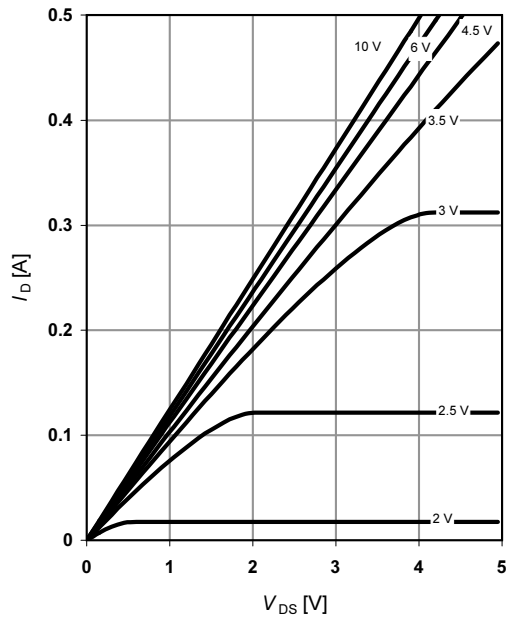
parameter:  $D = t_p/T$



**5 Typ. output characteristics**

$$I_D = f(V_{DS}); T_j = 25\text{ °C}$$

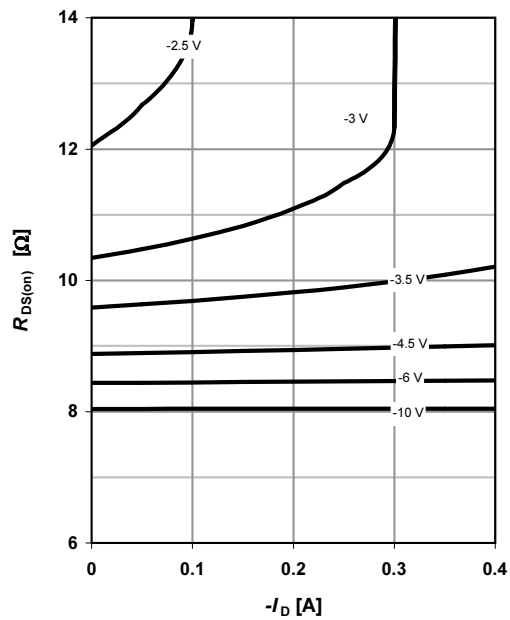
parameter:  $V_{GS}$



**6 Typ. drain-source on resistance**

$$R_{DS(on)} = f(I_D); T_j = 25\text{ °C}$$

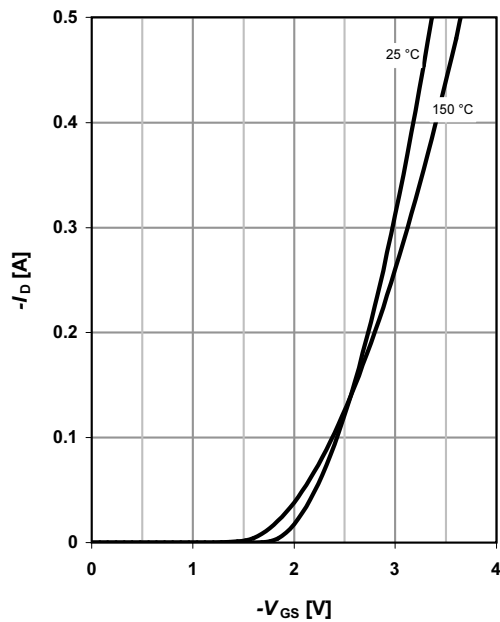
parameter:  $V_{GS}$



**7 Typ. transfer characteristics**

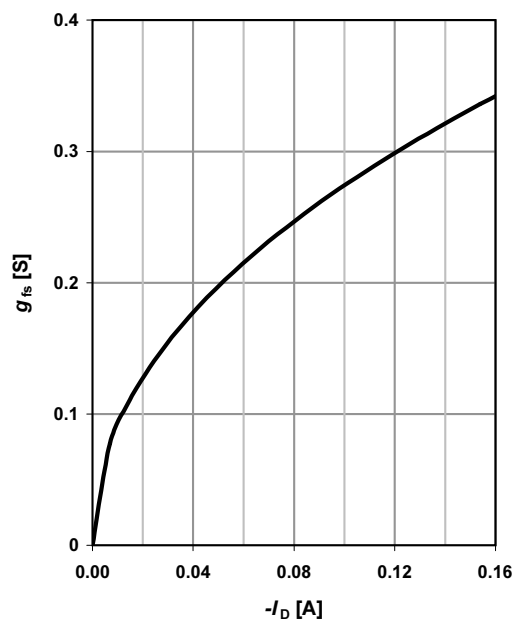
$$I_D = f(V_{GS}); |V_{DS}| > 2|I_D|R_{DS(on)max}$$

parameter:  $T_j$



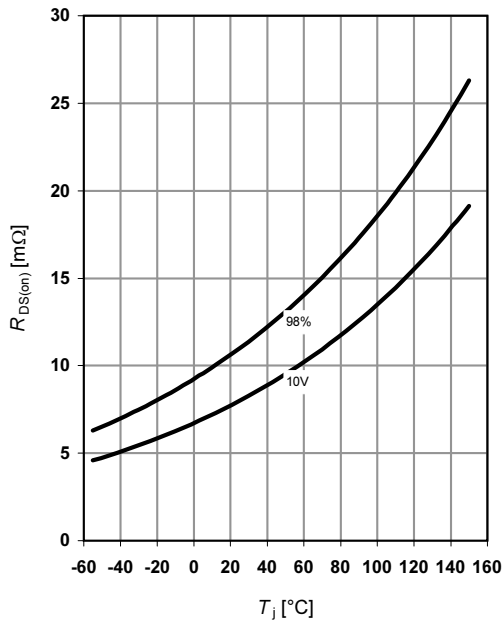
**8 Typ. forward transconductance**

$$g_{fs} = f(I_D); T_j = 25\text{ °C}$$



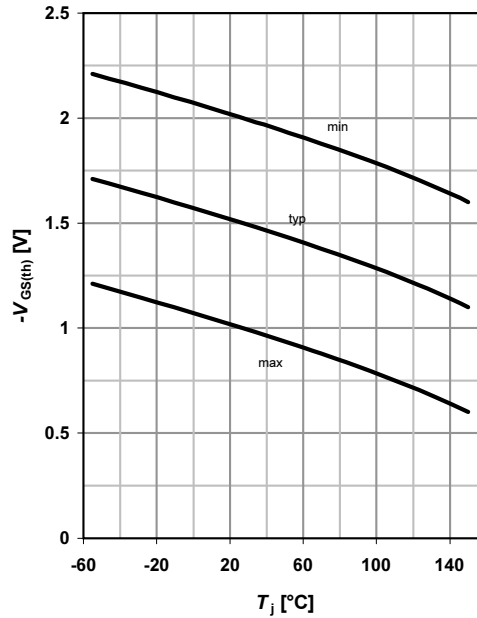
**9 Drain-source on-state resistance**

$$R_{DS(on)} = f(T_j); I_D = -0.14 \text{ A}; V_{GS} = -10 \text{ V}$$



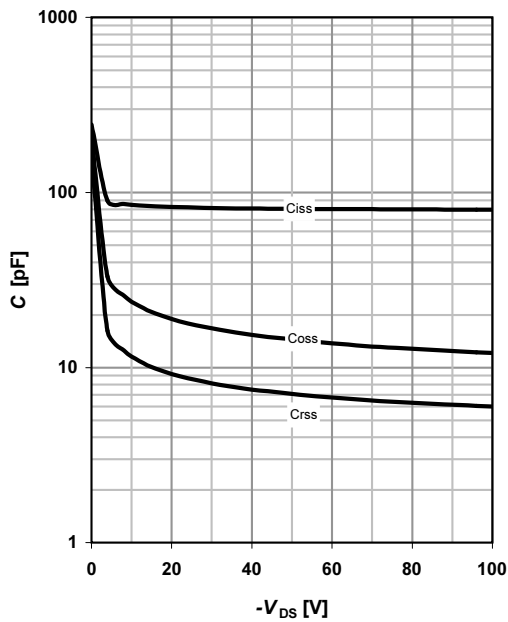
**10 Typ. gate threshold voltage**

$$V_{GS(th)} = f(T_j); V_{GS} = V_{DS}; I_D = -130 \mu\text{A}$$



**11 Typ. capacitances**

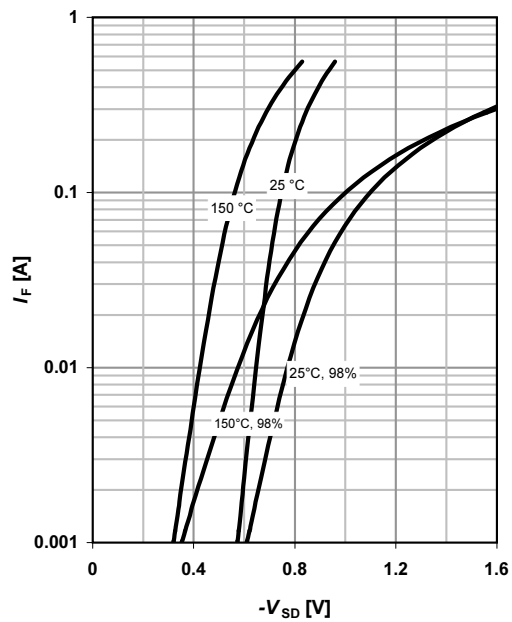
$$C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$$



**12 Forward characteristics of reverse diode**

$$I_F = f(V_{SD})$$

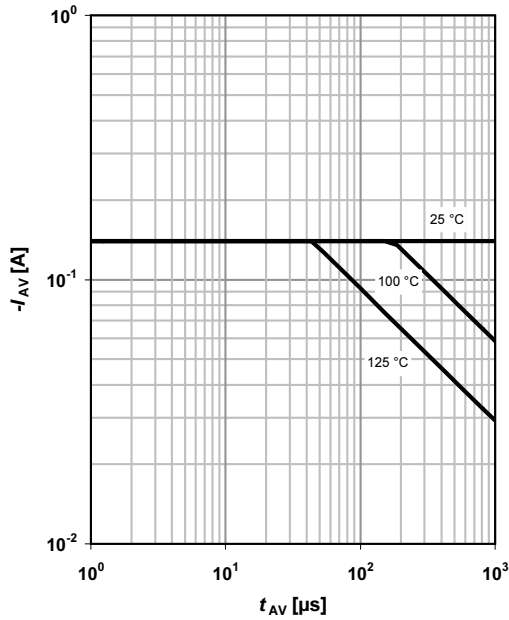
parameter:  $T_j$



**13 Avalanche characteristics**

$I_{AS}=f(t_{AV}); R_{GS}=25 \Omega$

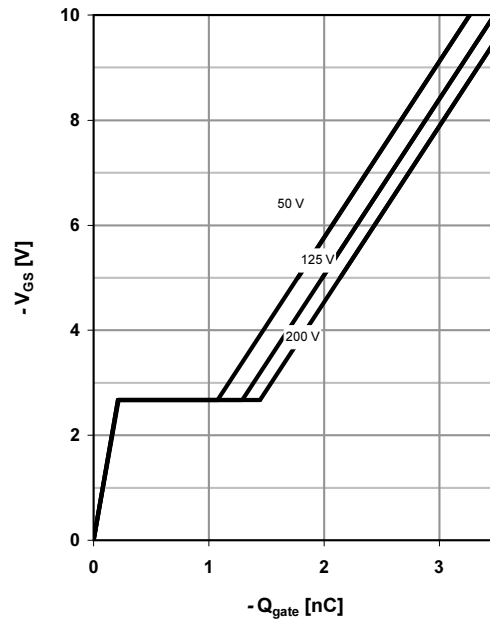
parameter:  $T_{j(start)}$



**14 Typ. gate charge**

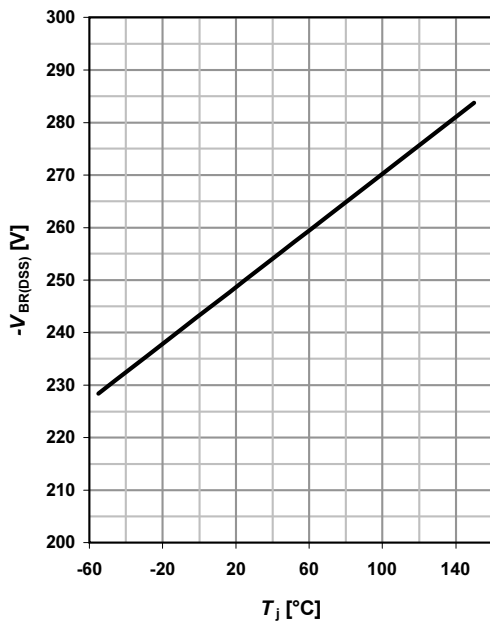
$V_{GS}=f(Q_{gate}); I_D=-0.14$  A pulsed

parameter:  $V_{DD}$

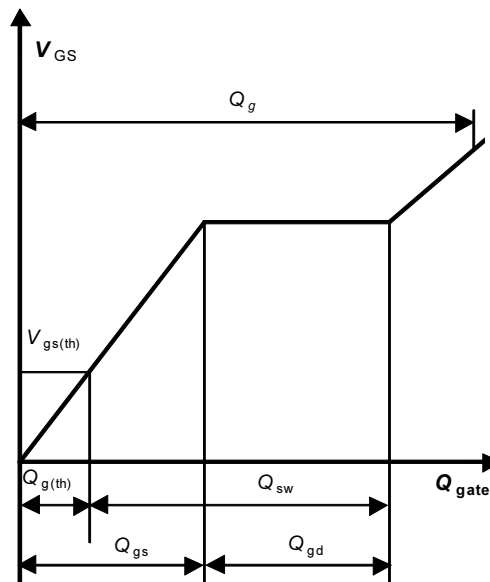


**15 Drain-source breakdown voltage**

$V_{BR(DSS)}=f(T_j); I_D=-250 \mu$ A

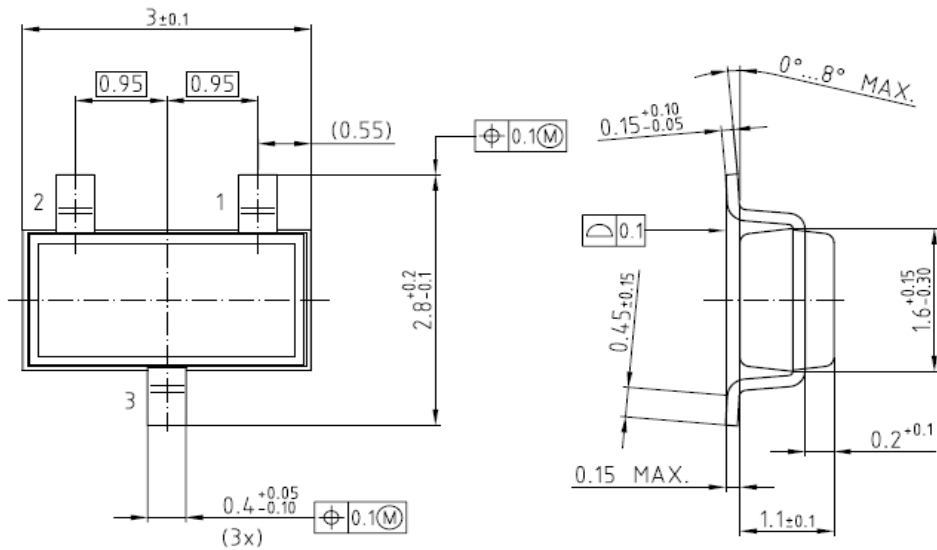


**16 Gate charge waveforms**

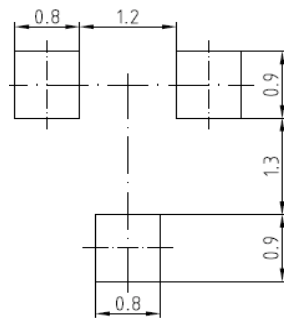


Package Outline

SC-59: Outline

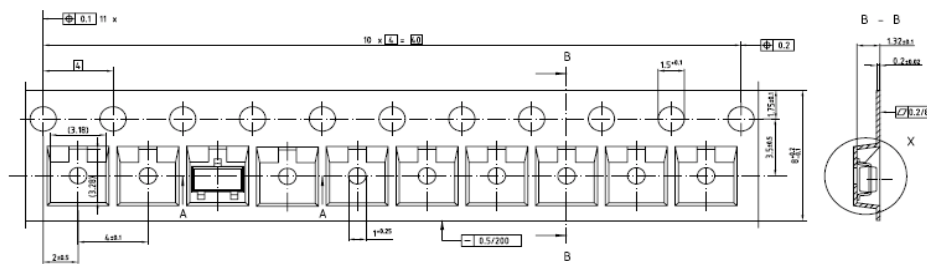


Footprint



Packaging

Tape



Dimensions in mm



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